Notice of References Cited Application/Control No. 09/748,716 Examiner Brian J Detwiler Applicatit(s)/Patent Under Reexamination DEAN ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0087571	07-2002	Stapel et al.	707/100
	В	US-2002/0085020	07-2002	Carroll, Thomas J. JR.	345/700
	С	US-2002/0026461	02-2002	Kutay et al.	707/523
	D	US-6,725,426	04-2004	Pavlov, John E.	715/523
	Ε	US-6,721,727	04-2004	Chau et al.	707/3
	F	US-6,356,920	03-2002	Vandersluis, Kirstan A.	715/501.1
	G	US-6,342,907	01-2002	Petty et al.	345/762
	н	US-			
	ı	US-			
ĺ	J	US-			
	к	US-			
	L	US-			
	М	US-	1.1 1.		, ,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*	ļ	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Provisional Application 60/232,515
	V	
	w	Best Available Copy
	х	DESI AVUITURE SOPY

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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